

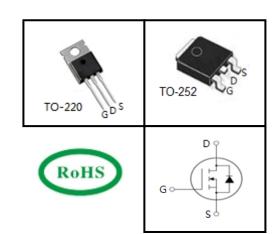
30V N-Channel Trench MOSFET

FEATURES

- Trench Power MOSFET Technology
- Low R_{DS(ON)}
- Low Gate Charge
- Optimized For Fast-switching Applications

APPLICATIONS

- Synchronous Rectification in DC/DC and AC/DC Converters
- Isolated DC/DC Converters in Telecom and Industrial



Device Marking and Package Information			
Device Package		Marking	
TTP120N03AT	TO-220	120N03AT	
TTD120N03AT	TO-252	120N03AT	

Absolute Maximum Ratings $T_C = 25^{\circ}C$, unless otherwise noted			
P	O. washad	Value	
Parameter	Symbol	TO-220, TO-252	Unit
Drain-Source Voltage (V _{GS} = 0V)	V _{DSS}	30	V
Continuous Drain Current	I _D	120	А
Pulsed Drain Current (r	ote1) I _{DM}	480	А
Gate-Source Voltage	V _{GSS}	±20	V
Single Pulse Avalanche Energy (n	ote2) E _{AS}	135	mJ
Avalanche Current (n	ote1) I _{As}	30	А
Power Dissipation (T _C = 25°C)	P _D	120	W
Operating Junction and Storage Temperature Range	T_J,T_stg	-55~+175	°C

Thermal Resistance			
Parameter	Symbol	Value	Unit
Parameter	Symbol	TO-220, TO-252	
Thermal Resistance, Junction-to-Case	R _{thJC}	1.24	12.007
Thermal Resistance, Junction-to-Ambient	R _{thJA}	60	K/W

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Specifications T _J = 25°C, ur	1000 01110	Wide Heled				
Parameter	Symbol	Test Conditions	Value			Unit
			Min.	Тур.	Max.	
Static		1				
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	30			V
Zero Gate Voltage Drain Current	l	$V_{DS} = 30V, V_{GS} = 0V, T_{J} = 25^{\circ}C$			1	пΔ
Zero Gate Voltage Brain Garrent	I _{DSS}	$V_{DS} = 30V, V_{GS} = 0V, T_{J} = 125^{\circ}C$			100	μA
Gate-Source Leakage	I_{GSS}	$V_{GS} = \pm 20V$			±100	nA
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1	1.7	2.4	V
Desir Ossess Os Basistanas (Nata)		$V_{GS} = 10V, I_{D} = 20A$		2.6	3.4	mΩ
Drain-Source On-Resistance (Note3)	$R_{DS(on)}$	V _{GS} = 4.5V, I _D = 20A		3.6	4.7	mΩ
Forward Transconductance (Note3)	g _{fs}	$V_{DS} = 10V, I_{D} = 20A$		30.2		S
Dynamic						
Input Capacitance	C _{iss}	V 0V		5782		
Output Capacitance	C _{oss}	$V_{GS} = 0V,$ $V_{DS} = 25V,$		465		pF
Reverse Transfer Capacitance	C _{rss}	f = 1.0MHz		376		
Total Gate Charge	Q_g			89		
Gate-Source Charge	Q_{gs}	$V_{DD} = 15V, I_{D} = 30A,$ $V_{GS} = 10V$		9		nC
Gate-Drain Charge	Q_{gd}			16		
Turn-on Delay Time	t _{d(on)}			12		
Turn-on Rise Time	t _r	$V_{DD} = 20V, I_{D} = 30A,$		11		
Turn-off Delay Time	t _{d(off)}	$R_G = 3\Omega$		40		ns
Turn-off Fall Time	t _f			12		
Drain-Source Body Diode Characteris	stics				<u> </u>	
Continuous Body Diode Current	I _S	T _C = 25°C			120	_
Pulsed Diode Forward Current	I _{SM}				480	А
Body Diode Voltage	V _{SD}	$T_J = 25^{\circ}C$, $I_{SD} = 30A$, $V_{GS} = 0V$			1.2	V
Reverse Recovery Time	t _{rr}	I _F = 30A,		60		ns
Reverse Recovery Charge	Q _{rr}	$di_{F}/dt = 100A/\mu s$		120		nC

Notes

- 1. Repetitive Rating: Pulse Width limited by maximum junction temperature
- 2. I_{AS} = 30A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25 $^{\circ}$ C
- 3. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 1%

Typical Characteristics $T_J = 25^{\circ}\text{C}$, unless otherwise noted

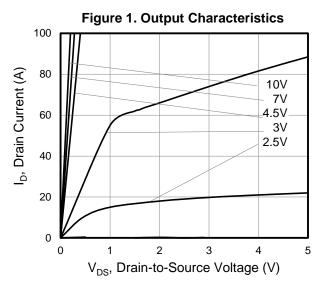


Figure 3. On-Resistance vs. Drain Current

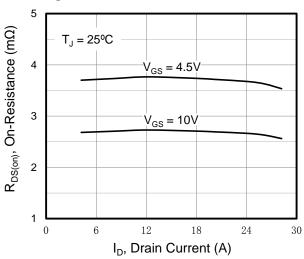


Figure 5. Gate Charge

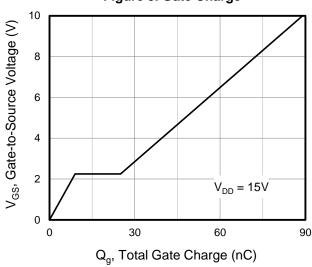


Figure 2. Transfer Characteristics

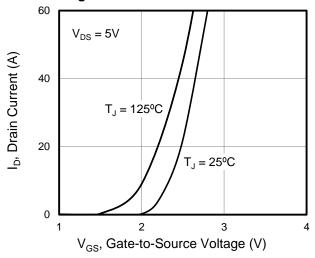


Figure 4. Capacitance

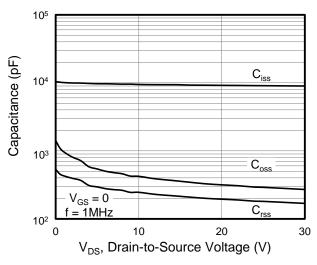
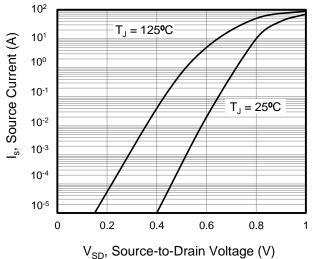


Figure 6. Body Diode Forward Voltage





Typical Characteristics $T_J = 25^{\circ}\text{C}$, unless otherwise noted

Figure 7. On-Resistance vs.

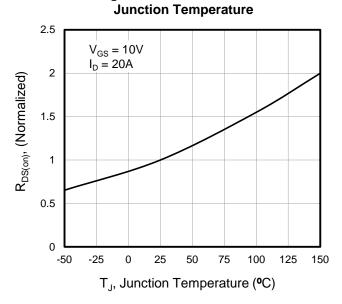


Figure 8. Threshold Voltage vs. Junction Temperature

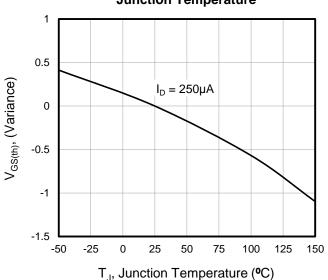
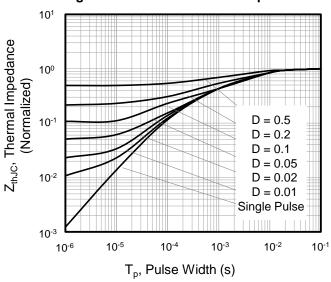


Figure 9. Transient Thermal Impedance



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Figure A: Gate Charge Test Circuit and Waveform

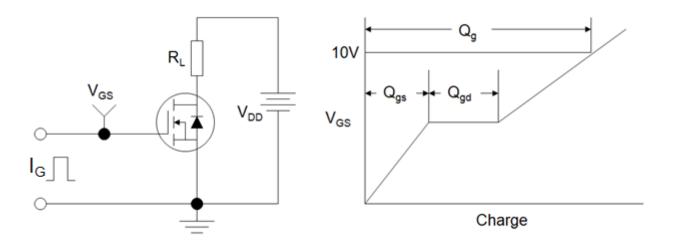


Figure B: Resistive Switching Test Circuit and Waveform

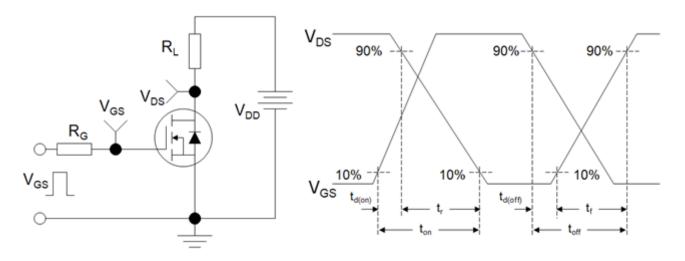
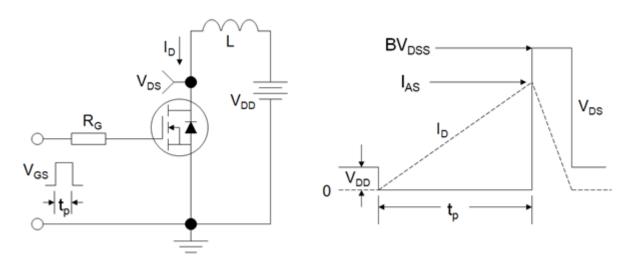


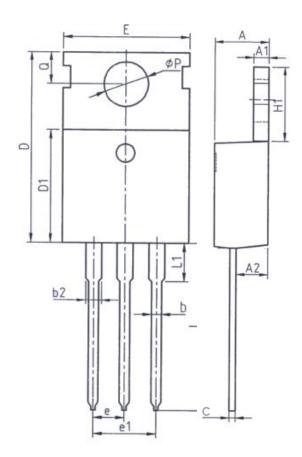
Figure C: Unclamped Inductive Switching Test Circuit and Waveform

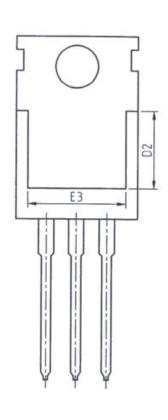


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TO-220

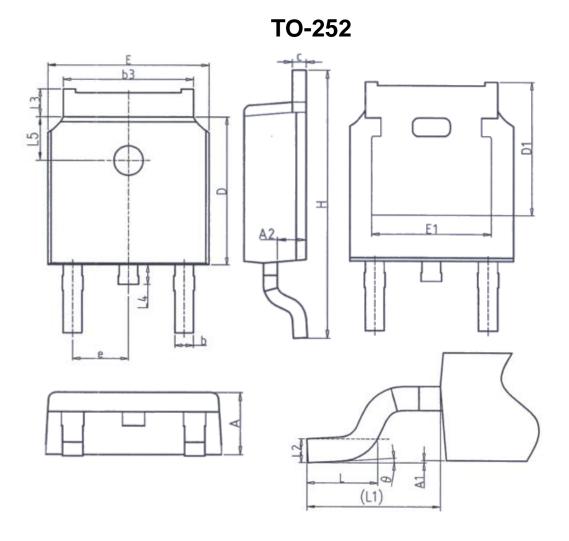




Unit: mm			
Symbol	Min.	Max.	
Α	4. 37	4. 77	
A1	1. 25	1. 45	
A2	2. 20	2. 60	
ь	0. 70	0. 95	
b2	1. 17	1. 47	
С	0. 40	0. 65	
D	15. 10	16. 10	
D1	8. 80	9. 40	
D2	5. 50	_	

Unit: mm			
Symbol	Min.	Max.	
E	9. 70	10. 30	
E3	7. 00	-	
е	2. 54BSC		
e1	5. 08BSC		
H1	6. 25	6. 85	
L	12. 75	13.80	
L1	-	3. 40	
P	3. 40	3. 80	
Q	2. 60	3. 00	





Unit: mm			
Symbol	Min.	Max.	
Α	2. 20	2. 40	
A1	0.00	0. 20	
A2	0. 97	1. 17	
b	0. 68	0.90	
b3	5. 20	5. 50	
С	0. 43	0. 63	
D	5. 98	6. 22	
D1 5. 30REF			
E	6. 40	6. 80	
E1	4. 63	_	

Unit: mm			
Symbol	Min.	Max.	
е	e 2. 286BSC		
Н	9. 40	10.50	
L	1. 38	1. 75	
L1	L1 2. 90REF		
L2	0. 51	IBSC	
L3	0.88	1. 28	
L4	- 1.00		
L5	1. 65	1. 95	
θ	0°	8°	



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